



Vishay Siliconix

N-Channel 30 V (D-S) MOSFET

PRODUCT SUMMARY						
V _{DS} (V)	$R_{DS(on)}(\Omega)$ (Max.)	I _D (A) ^f	Q _g (Typ.)			
30	0.0075 at V _{GS} = 10 V	38.3	6.9 nC			
	0.0120 at V _{GS} = 4.5 V	30.2	0.9110			

Thin PowerPAK® 1212-8 3 30 mm .30 mm

Ordering Information: SiS322DNT-T1-GE3 (Lead (Pb)-free and Halogen-free)

Bottom View

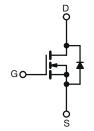
FEATURES

- TrenchFET® Gen IV Power MOSFET
- 100 % R_{α} and UIS Tested
- Thin 0.75 mm height
- Material categorization: For definitions of compliance please see www.vishav.com/doc?99912



APPLICATIONS

- Switch Mode Power Supplies
- Personal Computers and Servers
- Telecom Bricks
- VRM's and POL



N-Channel MOSFET

ABSOLUTE MAXIMUM RATIN	IGS (T _A = 25 °C	, unless oth	erwise noted)		
Parameter		Symbol	Limit	Unit	
Drain-Source Voltage		V_{DS}	30	V	
Gate-Source Voltage		V_{GS}	+ 20, - 16		
	T _C = 25 °C		38.3		
Continuous Drain Current (T _{.1} = 150 °C)	T _C = 70 °C	<u> </u>	30.6		
Continuous Drain Current (1 _J = 150 °C)	T _A = 25 °C	- I _D	15.3 ^{a, b}		
	T _A = 70 °C		12.1 ^{a, b}		
Pulsed Drain Current (t = 300 μs)		I _{DM}	70	Α	
Continuous Source-Drain Diode Current	T _C = 25 °C	1	18		
Continuous Source-Drain Diode Current	T _A = 25 °C	l _S	2.9 ^{a, b}		
Single Pulse Avalanche Current	L = 0.1 mH	I _{AS}	10		
Single Pulse Avalanche Energy	L = 0.1 IIII	E _{AS}	5	mJ	
	T _C = 25 °C		19.8		
Maximum Dawar Dissination	T _C = 70 °C	P _D	12.7	W	
Maximum Power Dissipation	T _A = 25 °C		3.2 ^{a, b}		
	T _A = 70 °C		3 ^{a, b}	1	
Operating Junction and Storage Temperature Range		T _J , T _{stg}	- 55 to 150	°C	
Soldering Recommendations (Peak Temperature) ^{c, d}			260]	

THERMAL RESISTANCE RATINGS						
Parameter		Symbol	Typical	Maximum	Unit	
Maximum Junction-to-Ambient ^{a, e}	t ≤ 10 s	R _{thJA}	31	39	°C/W	
Maximum Junction-to-Case (Drain)	Steady State	R _{thJC}	5	6.3] 0/**	

Notes:

- a. Surface mounted on 1" x 1" FR4 board.
- c. See solder profile (www.vishav.com/doc?73257). The Thin PowerPAK 1212-8 is a leadless package. The end of the lead terminal is exposed copper (not plated) as a result of the singulation process in manufacturing. A solder fillet at the exposed copper tip cannot be guaranteed and is not required to ensure adequate bottom side solder interconnection.
- d. Rework conditions: manual soldering with a soldering iron is not recommended for leadless components.
- e. Maximum under steady state conditions is 81 °C/W.
- f. Based on $T_C = 25$ °C.

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Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit	
Static					l	<u> </u>	
Drain-Source Breakdown Voltage	V _{DS}	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$	30			V	
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	1 050 A		18.5		mV/°C	
V _{GS(th)} Temperature Coefficient	$\Delta V_{GS(th)}/T_J$	I _D = 250 μA		- 5.2			
Gate-Source Threshold Voltage	V _{GS(th)}	$V_{DS} = V_{GS}$, $I_{D} = 250 \mu A$	1.2		2.4	V	
Gate-Source Leakage	I _{GSS}	V _{DS} = 0 V, V _{GS} = + 20 V, - 16 V			± 100	nA	
Zero Gate Voltage Drain Current	I _{DSS}	$V_{DS} = 30 \text{ V}, V_{GS} = 0 \text{ V}$			1	μΑ	
		V _{DS} = 30 V, V _{GS} = 0 V, T _J = 55 °C			10		
On-State Drain Current ^a	I _{D(on)}	$V_{DS} \ge 5 \text{ V}, V_{GS} = 10 \text{ V}$	30			Α	
	R _{DS(on)}	$V_{GS} = 10 \text{ V}, I_D = 10 \text{ A}$		0.0060	0.0075	Ω	
Drain-Source On-State Resistance ^a		$V_{GS} = 4.5 \text{ V}, I_D = 8 \text{ A}$		0.0096	0.0120		
Forward Transconductance ^a	9 _{fs}	$V_{DS} = 15 \text{ V}, I_{D} = 10 \text{ A}$		54		S	
Dynamic ^b	l. I				l		
Input Capacitance	C _{iss}			1000		pF	
Output Capacitance	C _{oss}			287			
Reverse Transfer Capacitance	C _{rss}	$V_{DS} = 15 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHz}$		34			
C _{rss} /C _{iss} Ratio				0.034	0.068		
		$V_{DS} = 15 \text{ V}, V_{GS} = 10 \text{ V}, I_{D} = 10 \text{ A}$		14.3	21.5		
Total Gate Charge	Q _g			6.9	10.5		
Gate-Source Charge	Q _{gs}	$V_{DS} = 15 \text{ V}, V_{GS} = 4.5 \text{ V}, I_{D} = 10 \text{ A}$		2.8		nC	
Gate-Drain Charge	Q _{gd}	30 30 2		1.6			
Output Charge	Q _{oss}	V _{DS} = 15 V, V _{GS} = 0 V		7.8			
Gate Resistance	R_{g}	f = 1 MHz	0.4	1.6	3.2	Ω	
Turn-On Delay Time	t _{d(on)}			15	30		
Rise Time	t _r	$V_{DD} = 15 \text{ V}, R_{L} = 1.5 \Omega$		10	20	- - - -	
Turn-Off Delay Time	t _{d(off)}	$I_D \cong 10 \text{ A}, V_{GEN} = 4.5 \text{ V}, R_g = 1 \Omega$		15	30		
Fall Time	t _f			7	14		
Turn-On Delay Time	t _{d(on)}			11	22	ns	
Rise Time	t _r			9	18		
Turn-Off Delay Time	t _{d(off)}	$I_D \cong 10 \text{ A}, V_{GEN} = 10 \text{ V}, R_g = 1 \Omega$		15	30	= = 	
Fall Time	t _f			5	10		
Drain-Source Body Diode Characteristic					l		
Continuous Source-Drain Diode Current	I _S	T _C = 25 °C			18	Ι.	
Pulse Diode Forward Current	I _{SM}	-			70	A	
Body Diode Voltage	V _{SD}	I _S = 5 A, V _{GS} = 0 V		0.77	1.1	V	
Body Diode Reverse Recovery Time	t _{rr}	- 45		19	35	ns	
Body Diode Reverse Recovery Charge		Q_{rr} $I_F = 10 \text{ A, dl/dt} = 100 \text{ A/}\mu\text{s, T}_J = 25 °C$		7	14	nC	
Reverse Recovery Fall Time				10		ns	
Reverse Recovery Rise Time	t _b			9			

Notes:

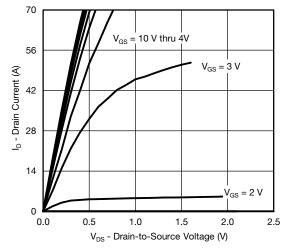
- a. Pulse test; pulse width \leq 300 $\mu s,$ duty cycle \leq 2 %
- b. Guaranteed by design, not subject to production testing.

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

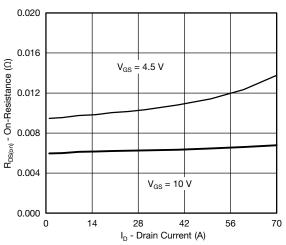


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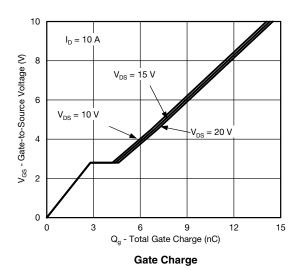
TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

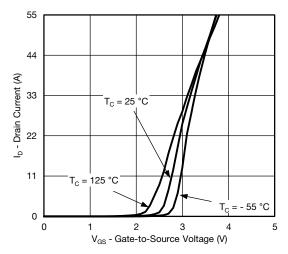


Output Characteristics

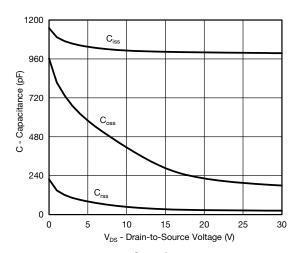


On-Resistance vs. Drain Current and Gate Voltage

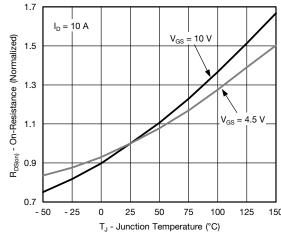




Transfer Characteristics



Capacitance



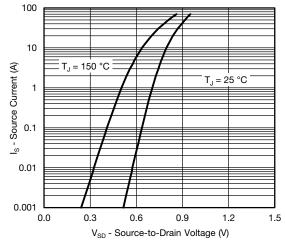
On-Resistance vs. Junction Temperature

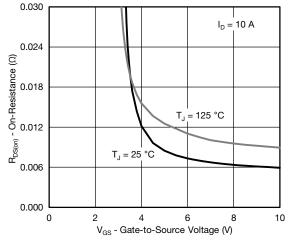
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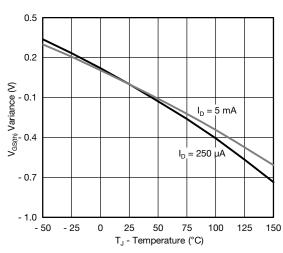
TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

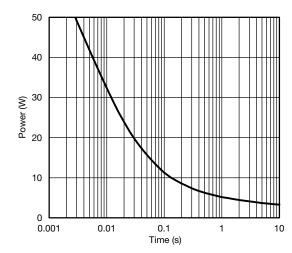




Source-Drain Diode Forward Voltage

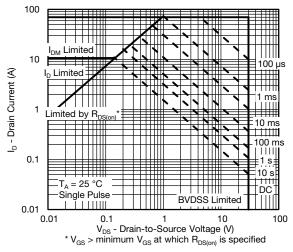
On-Resistance vs. Gate-to-Source Voltage





Threshold Voltage

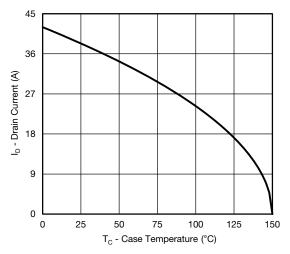
Single Pulse Power, Junction-to-Ambient



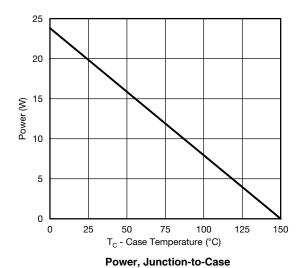


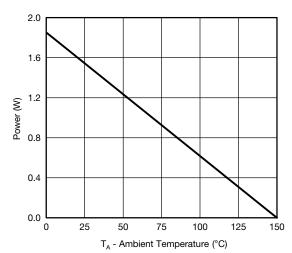
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TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



Current Derating*





Power, Junction-to-Ambient

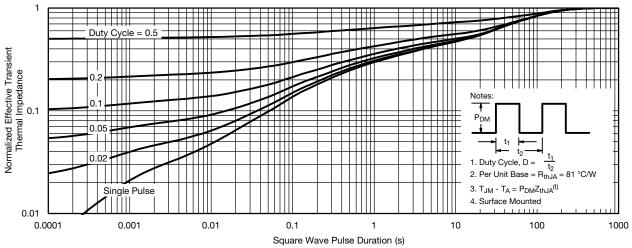
^{*} The power dissipation P_D is based on $T_{J(max.)} = 150$ °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.

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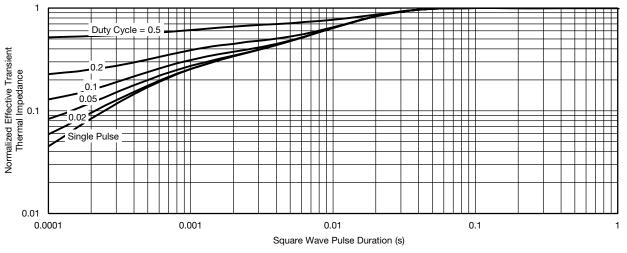
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TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



Normalized Thermal Transient Impedance, Junction-to-Ambient



Normalized Thermal Transient Impedance, Junction-to-Case

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